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TITLE: CHARGE TRANSFER DEVICE AND METHOD OF DRIVING THE SAME, AND
SOLD-STATE IMAGING DEVICE AND METHOD OF DRIVING THE SAME

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CHARGE TRANSFER DEVICE AND METHOD OF DRIVING THE SAME, AND
SOLID-STATE IMAGING DEVICE AND METHOD OF DRIVING THE SAME

BACKGROUND OF THE INVENTION

Field of the Invention

The present invention relates to a charge transfer device and a method of driving the same, and a solid-state imaging device and a method of driving the same.

Description of the Related Art

In recent years, higher quality cameras have been demanded in the field of an animation picture camera and a still picture camera.

Although, generally the number of picture elements of an imaging device is increased to raise the quality of such a picture, an increase of the number of picture elements delays a transfer rate upon frame transfer of a signal charge of the picture element or a so-called frame rate. Consequently, in an auto focus (AF: auto focus control) camera using output signals of an imaging device, an auto iris (AE, auto exposure control) camera, auto white balance (AWB) camera and the like, the feedback is delayed or it may be difficult to follow a motion of a camera or a movement of an object when a composition is determined while seeing an animation output in an electronic still camera.

FIG. 1 is a plan view of an example of a CCD imaging device 51 to be used in such a camera. This CCD imaging device 51 transfers a signal charge in a so-called inter-line transfer

method. In this imaging device, a plurality of light receiving units 52 made of a photo sensor are arranged in a matrix configuration. Each column of the light receiving units 52 is connected to a vertical CCD register 54 through a reading gate portion 53, and the vertical CCD registers 54 are connected to a horizontal CCD register 55. Charges from the horizontal CCD register 55 are converted through an output circuit such as an amplifier 56 or the like a voltage and then outputted as an output voltage V_{out} .

In the vertical CCD register 54, vertical drive pulses $\phi V1$, $\phi V2$, $\phi V3$, $\phi V4$ are applied to its transfer electrode and the signal charges are transferred in the 4-phase driving.

On the other hand, in the horizontal CCD register 55, horizontal drive pulses $\phi H1$, $\phi H2$ are applied alternately to the transfer electrodes arranged corresponding to each column of the respective light receiving unit and the signal charges are transferred in the 2-phase driving as described later.

To solve the above problem, that is, to raise the frame rate, it can be considered to increase the driving frequency of the CCD register of the CCD imaging device or the system. However, if the driving frequency is increased, its power consumption will resultantly increase.

In the CCD imaging device, a correlated double sampling (CDS) is carried out so as to cancel a reset noise or the like. If the driving frequency is raised, a necessity of carrying out the phase adjustment of sampling hold pulse in this

sampling arises so that production efficiency drops.

As a means for making a horizontal scanning period half without increasing the data rate from the CCD imaging device, there are a method of adding two horizontal picture elements by floating diffusion (FD) by doubling the drive frequency of the horizontal CCD register and a method of adding two picture elements at the final stage by doubling the drive frequency of a stage other than the final stage of the horizontal CCD register. However, in any cases, the shape of output waveform is changed, so that the preset period or data period of the output waveform which can be sampled by the correlated double sampling or the like is reduced.

FIG. 2 shows a configuration of a 2-phase drive horizontal CCD register of the CCD imaging device 51 shown in FIG. 1 and its potential in the transfer direction. FIG. 3 shows the drive pulses $\phi H1$, $\phi H2$ and the CCD output waveform upon a normal operation of the horizontal CCD register.

In the horizontal CCD register 55, as shown in FIG. 2, a plurality of transfer electrodes 57 comprising a storage electrode 57s made of multi-crystal silicone of a first layer, and a transfer electrode 57t made of multi-crystal silicone of a second layer are arranged on a semiconductor substrate through an insulation film in the electrode transfer direction so as to form a plurality of transfer portions. A first phase drive pulse $\phi H1$ is applied to the transfer electrode 57 of every second transfer portion, and a second phase drive pulse $\phi H2$ is

applied to the transfer electrode 57 of every other transfer portion, so that the signal charge is transferred by a so-called 2-phase complementary drive.

That is, as shown in FIG. 2, at a time point T1, the first phase drive pulse $\phi H1$ becomes a high level while the second phase drive pulse $\phi H2$ becomes a low level, so that the potential of the transfer portion to which $\phi H1$ is to be applied becomes deep and then a signal charge e is transferred thereto.

Next, at a time point T2, the first phase drive pulse $\phi H1$ becomes a low level while the second phase drive pulse $\phi H2$ becomes a high level, so that the potential of the transfer electrode portion to which $\phi H2$ is to be applied becomes deep and hence the signal charge is transferred from the transfer portion to which $\phi H1$ is to be applied to the transfer portion to which $\phi H2$ is to be applied.

In this manner, the signal charges are successively transferred in the transfer direction by the 2-phase drive pulses $\phi H1$, $\phi H2$.

The transfer portion at the final stage of the horizontal CCD register 55 is so constructed that the first phase drive pulse $\phi H1$ is applied thereto. At the time point T2, the signal charge is transferred from the horizontal CCD register 55 to the floating diffusion (FD) (not shown) and converted to a signal voltage.

After a signal is read through the floating diffusion (FD), a reset gate pulse ϕ_{RG} is applied to a reset gate portion adjacent to the floating diffusion (FD) so that the charge of the floating diffusion (FD) is reset.

Thus, a CCD output waveform shown in FIG. 3 is obtained.

A portion T_p in the CCD output waveform is a section which indicates a preset signal and a portion therein T_d is a section which indicates a data signal.

As for the output signal from the CCD imaging device, generally so as to improve an S/N ratio, first the correlated double sampling, that is, the preset signal T_p is clamped and then the data signal portion T_d is sampled.

Meantime, if the number of picture elements is increased to improve the picture quality, a fetch speed of one picture screen, that is, a so-called frame rate is retarded, so that feedback of AF, AE, AWB or the like using the CCD output signal is delayed or it becomes difficult to display the same on a liquid crystal screen or the like to confirm its composition.

To improve such a defect, there is a method of doubling the drive frequency of, for example, the horizontal CCD register so as to quicken the output data rate.

FIG. 4 shows a horizontal drive pulse and a CCD output waveform of this case.

Because the drive frequency is doubled, the wavelengths of the horizontal drive pulse ϕ_{H1} , ϕ_{H2} and the reset

gate pulse ϕ_{RG} become half respectively and the period of the CCD output waveform also becomes half.

However, in this case, widths T_{p2} , T_{d2} of the portions for carrying out the clamp or sampling become half as compared to a usual case, so that the phase of a clamp pulse or sampling pulse needs to be adjusted one by one thereby reducing production efficiency.

Further, because the data rate doubles, the signal processing speed also doubles so that power consumption and noise increase. Further, because the system design is limited, disadvantage arises in production cost.

On the other hand, as a method of doubling the scanning speed of the horizontal CCD register without changing the data rate, there is a method of adding signal charge of two horizontal picture elements at the floating diffusion (FD).

FIG. 5 shows a horizontal drive pulse and a CCD output waveform of this case.

According to this method, the lengths of a preset period T_{p3} and a data period T_{d3} become half as compared to the usual case like T_{p2} and T_{d2} , respectively. Therefore, the phases of the clamp pulse and sampling pulse must be adjusted.

This is because T_{p3} is limited by the high level period of a first time of the horizontal drive pulse ϕ_{H1} and T_{d3} is limited by the low level period of a second time of the horizontal drive pulse ϕ_{H1} .

FIG. 6 is a sectional view showing the horizontal

transfer register of a solid-state imaging device, for example, a CCD area sensor. Referring to FIG. 6, an N type transfer channel 103 is formed on the surface side of an N type substrate 101 with a P type well 102 disposed therebetween. On the N type transfer channel 103 are arranged gate electrodes 104, 105 of first and second layers, which are formed of polysilicone or the like through a gate insulating film (not shown), alternately in the portion direction.

In the surface portion of the transfer channel 103 below the gate electrode 105 is ion-implanted an N- impurity. The gate electrodes 104, 105 of the first and second layers adjacent to each other serve as a pair and horizontal transfer clocks $\phi H1$, $\phi H2$ having opposite phase to each other as shown in FIG. 7 are applied to each pair of the gate electrodes 104, 105 alternately. The horizontal transfer clocks $\phi H1$, $\phi H2$ carry out complementary drive for the horizontal transfer register.

A transfer operation on the horizontal transfer register having the aforementioned structure will be described with reference to a potential diagram shown in FIG. 8. FIG. 8 shows potential distribution at each of timings T1-T4 of FIG. 7.

Because the horizontal transfer clock $\phi H1$ of the first phase is of high level (hereinafter referred to as "H" level) while the horizontal transfer clock $\phi H2$ of the second phase is of low-level (hereinafter referred to as "L" level) when $T = T1$, the potential under the gate electrodes 104, 105 of $\phi H1$ becomes

deep. Further, because the potential under the gate electrode 104 is deeper than the potential under the gate electrode 105, the signal charge is accumulated under the gate electrode 104 of $\phi H1$.

When $T = T2$, the horizontal transfer clock $\phi H1$ of the first phase is of L level and the horizontal transfer clock $\phi H2$ of the second phase is of H level. Thus, the potential under the gate electrodes 104, 105 of $\phi H1$ becomes shallow and the potential under the gate electrodes 104, 105 of $\phi H2$ becomes deep. Consequently, the signal charge accumulated under the gate electrode 104 of $\phi H1$ is transferred to the gate electrodes 104, 105 of $\phi H2$. Because the potential of the portion under the gate electrode 104 is deeper than the potential of the portion under the gate electrode 105, the signal charge is accumulated under the gate electrode 104 of $\phi H2$.

When $T = T3$, the horizontal transfer clock $\phi H1$ of the first phase is of H level and the horizontal transfer clock $\phi H2$ of the second phase is of L level. Thus, the potential under the gate electrodes 104, 105 of $\phi H1$ becomes deep and the potential under the gate electrodes 104, 105 of $\phi H2$ becomes shallow. Further, because the potential of the portion under the gate electrode 104 is deeper than the potential of the

portion under the gate electrode 105, the signal charge accumulated under the gate electrode 104 of $\phi H2$ is transferred to the gate electrodes 104, 105 of $\phi H1$ and accumulated under the gate electrode 104.

After $T = T4$, the same operation is repeated. By this series transfer operation, the horizontal transfer of the signal charge by one horizontal picture element is carried out in one cycle of the horizontal transfer clocks $\phi H1$, $\phi H2$. The signal charge transferred horizontally is supplied successively to a charge detecting portion (not shown) through a horizontal output gate and converted to a signal voltage at this charge detecting portion so as to produce a CCD output.

However, the CCD sensor has a problem that the frame rate drops with a tendency of increased picture elements in recent years. If the frame rate drops, feedback at the time of photometry upon exposure adjustment is delayed in, for example, a camera system equipped with the CCD area sensor. Further, if the frame rate drops, the signal charge accumulation time is prolonged, so that deterioration of picture quality due to a dark signal is a problem to be solved.

As a method for increasing the frame rate in a multi-picture element CCD area sensor, there are a method of selectively reading the signal charge from picture element in the vertical direction and a method of thinning lines in the vertical direction by selectively throwing out the signal charge transferred from the vertical transfer register to the

horizontal transfer register in the unit of each line, to a charge discharging portion provided beside the horizontal transfer register.

On the other hand, as a method for increasing the frame rate by reducing the output period of one horizontal line (1H), there is only a method of raising the frequency of the horizontal transfer clocks $\phi H1$, $\phi H2$ for driving the horizontal transfer register, that is, the horizontal drive frequency. However, if the horizontal drive frequency is raised, power consumption is increased and further in a signal processing system at the following step, clamp or sampling margin diminishes so that the CDS (correlated double sampling) becomes difficult.

SUMMARY OF THE INVENTION

In view of such aspects, it is an object of the present invention to provide a CCD imaging device which can make waveforms of outputs from the CCD imaging device upon a normal drive and an N-time speed drive and can carry out the sampling with sufficiently securing a period for a correlated double sampling and which reduces a horizontal scanning period to thereby make a feedback of an automatic control and a monitor output faster and is suitable for high picture quality by increasing the number of pixels.

It is another object of the present invention to provide a charge transfer device which can reduce an output period without changing a drive frequency and to provide a solid-state imaging device which can increase a frame rate

resulting from reduction of an output period of one horizontal line by using the above charge transfer device as a horizontal transfer register.

According to a first aspect of the present invention, a charge transfer device having a charge transfer portion in which a plurality of electrode pairs are formed above a transfer channel includes means for commonly wiring the plurality of electrode pairs forming N ($N=2, 3, 4, \dots$ natural numbers) bits of the charge transfer portion so that electrode pairs of each half bit can be independently driven at every N bits, means for, in a normal operation, inputting the electrode pairs of each half bit with the same drive pulse to operate it by a two-phase complementary drive, and means for, in an N -time speed operation, inputting the electrode pairs of N bits with N pairs of complementary drive pulses to operate them by a $2N$ -phase complementary drive.

According to a second aspect of the present invention, a method of driving a charge transfer device having a charge transfer portion in which a plurality of electrode pairs are formed above a transfer channel and arranged such that the plurality of electrode pairs forming N ($N=2, 3, 4, \dots$ natural numbers) bits of the charge transfer portion are wired at every N bits so that electrode pairs of each half bit can be independently driven at every N bits, includes a step of, in a normal operation, inputting the electrode pairs of each half bit with the same drive pulse to operate it by a two-phase complementary drive, and a step of, in an N -time speed

operation, inputting the electrode pairs of N bits with N pairs of complementary drive pulses to operate them by a 2N-phase complementary drive.

According to a third aspect of the present invention, a charge transfer device, includes an electrode structure formed of electrode pairs for first and second phases repeatedly and alternately arranged above a transfer channel in its transfer direction of and arranged such that the electrode pairs for the first phase located across the electrode pairs for the second phase can be independently driven, means for applying a DC voltage to the electrode pairs for the second phase, and means for supplying transfer clocks having a phase reverse each other to each of the electrode pairs for the first phase located across each of the electrode pairs for the second phase.

According to a fourth aspect of the present invention, a solid-state imaging device includes an imaging unit formed of a plurality of pixels for converting incident light into signal charges, and a charge transfer portion for transferring the signal charges read out from the plurality of pixels. The charge transfer portion having an electrode structure formed of electrode pairs for first and second phases repeatedly and alternately arranged above a transfer channel in its transfer direction of and wired such that the electrode pairs for the first phase located across the electrode pairs for the second phase can be independently driven, a mode setting unit for setting an operation mode, and means for, when the mode setting unit sets a first operation mode, supplying a DC voltage or a

transfer clock having a phase reverse to that of the transfer clock for the first phase to the electrode pair for the second phase and supplying a transfer clock having the same phase as that of the transfer clock to each of the electrode pairs located across the electrode pair for the second phase and for, when the mode setting unit sets a second operation mode, applying a DC voltage to the electrode pairs for the second phase and supplying the transfer clock having the reverse phase to each of the electrode pairs for the first phase located across the electrode pair for the second phase.

According to a fifth aspect of the present invention, a method of driving a solid-state imaging device which has an imaging unit formed of a plurality of pixels for converting incident light into signal charges, and a charge transfer portion for transferring the signal charges read out from the plurality of pixels and in which the charge transfer portion has an electrode structure formed of electrode pairs for first and second phases repeatedly and alternately arranged above a transfer channel in its transfer direction of and wired such that the electrode pairs for the first phase located across the electrode pairs for the second phase can be independently driven, includes a step of, in a first operation mode, supplying a DC voltage or a transfer clock having a phase reverse to that of a transfer clock for the electrode pairs for the first phase to the electrode pairs for the second phase and supplying a transfer clock having the same phase as that of the transfer clock to each of the electrode pairs located across the

electrode pair for the second phase, and a step of, in a second operation mode, applying a DC voltage to the electrode pairs for the second phase and supplying transfer clocks having the reverse phase to each of the electrode pairs for the first phase located across the electrode pair for the second phase.

BRIEF DESCRIPTION OF THE DRAWINGS

FIG. 1 is a schematic construction diagram (plan view) showing an example of a CCD imaging device;

FIG. 2 is a potential diagram in the transfer direction of a conventional horizontal CCD register in a CCD imaging device;

FIG. 3 is a diagram illustrating a conventional horizontal drive clock pulse and a CCD output waveform of the CCD imaging device;

FIG. 4 a diagram illustrating a horizontal drive clock pulse and a CCD output waveform of a CCD imaging device in a double speed operation;

FIG. 5 is a diagram illustrating a horizontal drive clock pulse and a CCD output waveform of a CCD imaging device in FD adding operation;

FIG. 6 is a sectional view of a horizontal transfer register;

FIG. 7 is a waveform diagram of a 2-phase transfer clock;

FIG. 8 is a potential diagram for explaining an operation of the horizontal transfer register shown in FIG. 6;

FIG. 9 is a schematic construction view (plan view)

showing a first embodiment of a CCD imaging device according to the present invention;

FIG. 10 is a potential diagram in the transfer direction of the horizontal CCD register according to the embodiment of the CCD imaging device of the present invention;

FIG. 11 is a diagram showing a horizontal drive clock pulse and a CCD output waveform in double speed operation according to the embodiment of the CCD imaging device of the present invention;

FIGS. 12A, 12B are diagrams used to explain a transfer from a vertical CCD register to a horizontal CCD register in a double speed operation according to the embodiment of the CCD imaging device of the present invention, wherein FIG. 12A is a potential diagram of a final stage of the vertical CCD register and a horizontal CCD register and FIG. 12B is a timing chart showing a part of a vertical drive clock pulse and a horizontal drive clock pulse;

FIG. 13 is a diagram showing a horizontal drive clock pulse and a CCD output waveform in a normal operation of the embodiment of the CCD imaging device of the present invention;

FIG. 14 is a schematic construction view (plan view) showing a second embodiment of the CCD imaging device according to the present invention;

FIG. 15 is a schematic construction view (plan view) showing a third embodiment of the CCD imaging device according to the present invention;

FIG. 16 is a schematic construction view (plan view)

showing a fourth embodiment of the CCD imaging device according to the present invention;

FIG. 17 is a schematic construction view showing a CCD area sensor according to a fifth embodiment of the present invention;

FIGS. 18A, 18B are waveform diagrams of a horizontal transfer clock relating to the fifth embodiment of the present invention, wherein FIG. 18A shows a case of a normal operation mode and FIG. 18B shows a case of a frame rate increase operation mode;

FIG. 19 is a sectional view of the horizontal transfer register;

FIGS. 20A, 20B are diagrams for explaining the case of the normal operation mode, wherein FIG. 20A is a timing chart and FIG. 20B is a potential diagram;

FIGS. 21A, 21B are diagrams for explaining the case of the frame rate increase operation mode, wherein FIG. 21A is a timing chart and FIG. 21B is a potential diagram;

FIG. 22 is a schematic construction diagram showing a sixth embodiment of the present invention;

FIG. 23 is a schematic construction diagram showing a seventh embodiment of the present invention;

FIG. 24 is a plan pattern diagram showing a part of a construction of a control gate portion relating to the seventh embodiment; and

FIG. 25 is a schematic construction diagram showing an eighth embodiment of the present invention.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

Hereinafter, the embodiments of a CCD imaging device according to the present invention will be described with reference to the accompanying drawings.

FIG. 9 shows generally a CCD imaging device 1 according to the present embodiment. This CCD imaging device 1 is based on a so-called inter-line transfer system. A plurality of light receiving portions 2 each of which is made of a photo sensor and serving as a picture element are arranged in a matrix fashion and a vertical CCD register 4 is provided at every column of the light receiving portions 2 through a read-out gate 3 disposed adjacent each column of the light receiving portions 2. Each of the vertical CCD registers 4 is connected to a horizontal CCD register 5. A signal charge transferred through the horizontal CCD register 5 is converted through an output circuit such as an amplifier 6 or the like to an output voltage V_{out} , and then outputted. The vertical CCD register 4 is driven by, for example, 4-phase vertical driving pulses $\phi V1$, $\phi V2$, $\phi V3$, $\phi V4$.

According to the present embodiment, a structure of the horizontal CCD register 5 has a feature.

That is, as shown in FIG. 10, the horizontal CCD register 5 comprises a plurality of transfer electrodes 7 which are arranged in the electrode transfer direction, to form a plurality of transfer portions, 7W, 7X, 7Y, 7Z. Each of the transfer electrodes 7 comprises a storage electrode 7s which is

made of poly crystalline silicone of a first layer and a transfer electrode 7t made of polycrystalline silicone of a second layer formed on a semiconductor substrate 11 through an insulating film 12.

Wiring is formed so that four independent pulses, a first drive pulse $\phi H1a$, a second drive pulse $\phi H2a$, a third drive pulse $\phi H1b$ and a fourth drive pulse $\phi H2b$ which are independent one another are applied to the transfer electrodes 7 of the transfer portions 7W, 7X, 7Y, 7Z, at repeating of four and that the first drive pulse $\phi H1a$ is applied to the final stage transfer portion 7W in the transfer electrode 7. That is, the transfer portion to which the first drive pulse $\phi H1a$ is applied is assumed to be 7W and the transfer portions to which the second, third and fourth drive pulses $\phi H2a$, $\phi H1b$, $\phi H2b$ are applied are referred to as 7X, 7Y and 7Z.

Two adjacent transfer portions compose one bit and the two transfer portions correspond to the vertical CCD register 4 at each column.

A horizontal output gate portion 8 is formed adjacent to the transfer portion 7W at the final stage and further, a floating diffusion (FD) region 9 constituting a charge/voltage conversion portion, a reset gate portion 10 to which a reset gate pulse ϕRG is applied and a reset drain region 13 are formed.

A signal charge transferred to the transfer portion 7W

at the final stage is transferred to the floating diffusion region 9 through the horizontal output gate portion 8. After charge/voltage conversion is carried out in the floating diffusion region 9 and a signal is read, the charge in the floating diffusion region 9 is reset in the reset drain region 13 through the reset gate portion 10.

Next, an operation of the CCD imaging device 1 according to this embodiment, particularly an operation of the horizontal CCD register 5 will be described. FIG. 10 shows a potential diagram in the transfer direction of the horizontal CCD register 5 of the CCD imaging device 1 according to this embodiment. FIG. 11 shows the drive pulses $\phi H1a$, $\phi H1b$, $\phi H2a$, $\phi H2b$ in double speed operation of the horizontal CCD register 5 and a CCD output waveform. FIGS. 12A and 12B are diagrams used to explain the transfer from the vertical CCD register 4 to the horizontal CCD register 5. FIG. 13 shows the drive pulses $\phi H1$, $\phi H2$ under a normal operation of the horizontal CCD register and a CCD output waveform.

In the normal operation in which transfer is conducted at a normal speed, as shown in FIG. 13, the first drive pulse $\phi H1a$ and the third drive pulse $\phi H1b$ are of the same clock pulse and the second drive pulse $\phi H2a$ and the fourth drive pulse $\phi H2b$ are of the same clock pulse. Then, the first and third drive pulses $\phi H1a$, $\phi H1b$ and the second and fourth drive pulses $\phi H2a$,

$\phi H2b$ are made in opposite phase to each other, so that a so-called two-phase drive pulse is formed. Then, the signal charge is transferred by a so-called two-phase complementary drive. This drive is the same as the drive shown in FIGS. 2 and 3.

Next, the double speed operation will be described. The drive pulses ($\phi H1a$, $\phi H2a$, $\phi H1b$, $\phi H2b$) are set as shown in FIG. 11. That is, the first drive pulse $\phi H1a$ and the third drive pulse $\phi H1b$ are set in opposite phase to each other and the second drive pulse $\phi H2a$ and the fourth drive pulse $\phi H2b$ are set in opposite pulse to each other, while a set of the first and third drive pulses $\phi H1a$, $\phi H1b$ and a set of the second and fourth drive pulses $\phi H2a$, $\phi H2b$ are transferred in phase from each other (transferred by $1/2$ of a half wavelength of the pulse in this embodiment). Charges are transferred by the so-called four-phase complementary drive.

As shown in FIGS. 10, 11, at a time $T1$, the first drive pulse $\phi H1a$ is of high level, the third drive pulse $\phi H1b$ is of low level, the second drive pulse $\phi H2a$ is of high level and the fourth drive pulse $\phi H2b$ is of low level. Potentials of the transfer portions $7W$, $7X$ to which $\phi H1a$ and $\phi H2a$ are applied become deep. Thus, a signal charge e corresponding to each picture element is transferred to the portion under the storage electrode $7s$ of the transfer portions $7W$, $7X$ to which $\phi H1a$, $\phi H2a$

are to be applied.

At this time, a reset gate pulse ϕ_{RG} is applied so that the potential of the reset gate portion 10 becomes deep and the charge in the floating diffusion region 9 is reset. This reset gate pulse ϕ_{RG} is of the same phase as a reset gate pulse ϕ_{RG} in the normal operation with respect to the drive pulse ϕ_{H1a} of the transfer portion 7W at the final stage.

Next, at a time T2, the second and fourth drive pulses ϕ_{H2a} , ϕ_{H2b} are reversed so that the ϕ_{H2a} becomes the low level and the ϕ_{H2b} becomes the high level. Thus, the potential of the transfer portion 7X to which ϕ_{H2a} is to be applied becomes shallow and the potential of the transfer portion 7Z to which ϕ_{H2b} is to be applied becomes deep. Therefore, the charge at the transfer portion 7X of the ϕ_{H2a} is transferred to the transfer portion 7W of the ϕ_{H1a} at the final stage so that signal charge of two picture elements are added. The signal charge e at a middle portion is transferred from the transfer portions 7W, 7X of the ϕ_{H1a} , ϕ_{H2a} to the transfer portions 7Z, 7W of the ϕ_{H2b} , ϕ_{H1a} .

The reset gate portion 10 is turned off so that accumulation of the signal charge in the floating diffusion region 9 is enabled.

At a time T3, the first and third drive pulses ϕ_{H1a} ,

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 $\phi H1b$ are reversed so that the $\phi H1a$ becomes the low level and the $\phi H1b$ becomes the high level. The potential of the transfer portion 7W to which the $\phi H1a$ is to be applied becomes shallow and the potential of the transfer portion 7Y to which the $\phi H1b$ is to be applied becomes deep. The signal charge e of two picture elements added to the transfer portion 7W at the final stage is transferred to the floating diffusion region 9. At the same time the charge of the transfer portions 7Z, 7W of the $\phi H2b$, $\phi H1a$ are transferred to the transfer portions 7Y, 7Z of the $\phi H1b$, $\phi H2b$.

At a time T4, the second and fourth drive pulses $\phi H2a$, $\phi H2b$ are reversed again so that the $\phi H2a$ becomes the high level and the $\phi H2b$ becomes the low level. The potential of the transfer portion 7X to which the $\phi H2a$ is to be applied becomes deep and the potential of the transfer portion 7Z to which the $\phi H2b$ is to be applied becomes shallow. Then, the signal charge e is transferred from the transfer portions 7Y, 7Z of the $\phi H1b$, $\phi H2b$ to the transfer portions 7X, 7Y of the $\phi H2a$, $\phi H1b$.

After that, the same condition as the time T1 is attained. Again, the first and third drive pulses $\phi H1a$, $\phi H1b$ are reversed so that the $\phi H1a$ becomes the high level and the

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$\phi H1b$ becomes the low level. The potential of the transmitting portion 7W to which the $\phi H1a$ is to be applied becomes deep. The potential of the transfer portion 7Y to which the $\phi H1b$ is to be applied becomes shallow. Then, the signal charge e is transferred from the transfer portions 7X, 7Y of the $\phi H2a$, $\phi H1b$ to the transfer portions 7W, 7X of the $\phi H1a$, $\phi H2a$.

Because the reset gate pulse ϕRG is turned on, the signal charge e accumulated in the floating diffusion region 9 is reset.

By repeating the states of the times T1-T4, the signal charge e is successively transferred in the transfer direction.

Then, in a correlated double sampling circuit, the preset signal is clamped in an interval of the $Tp4$ of CCD output shown in FIG. 11 and a data signal is sampled in an interval of $Td4$ in FIG. 11.

Although in the normal operation, it takes one clock amount of $\phi H1a$ to move from H1a to H1b, under the double speed in this embodiment, transfer is enabled in a time of half clock from T2 to T4. That is, the horizontal scanning interval can be made half.

Meantime, FIGS. 12A, 12B show a charge transfer state in which the charge is transferred from the vertical CCD register 4 to the horizontal CCD register 5 so that the aforementioned time T1 is regained. The transfer from the

vertical CCD register 4 to the horizontal CCD register 5 is carried out in a horizontal blanking interval by the normal 4-phase drive.

FIG. 12A shows a potential diagram and FIG. 12B shows a drive clock pulse.

The drive pulse of the final stage transfer portion of the vertical CCD register 4 is $\phi V3$ and the signal charge is transferred to the transfer portion 7W to which the $\phi H1b$ is to be applied, of the horizontal CCD register.

After the horizontal CCD transfer is carried out in the horizontal scanning interval as set forth above, the horizontal blanking interval starts. First, at a time T5, the first and third drive pulses $\phi H1a$, $\phi H1b$ become high level and then the second and fourth drive pulses $\phi H2a$, $\phi H2b$ become low level. The signal charge is accumulated in the transfer portions 7W, 7Y to which the first and third drive pulses $\phi H1a$, $\phi H1b$ are applied. On the other hand, in the vertical CCD register 4, the drive pulse $\phi V2$ of a transfer portion just before the final stage becomes high level and the drive pulse $\phi V3$ of the transfer portion at the final stage becomes low level, so that the signal charge exists in the transfer portion just before the final stage.

Then, at a time T6, the drive pulse $\phi V3$ of the transfer portion at the final stage of the vertical CCD register

4 becomes high level, so that the potential of the transfer portion at the final stage and the potential of the transfer portion just before the final stage become the same depth.

Successively, at time T7, the drive pulse $\phi V2$ of the transfer portion just before the final stage of the vertical CCD register 4 becomes low level so that the signal charge is transferred to the transfer portion 7Y of the $\phi H1b$ of the horizontal CCD register 5 through the transfer portion at the final stage.

Next, at a time T8, the drive pulse $\phi V3$ at the final stage of the vertical CCD register 4 becomes low level also so that the remaining signal charge is transferred to the transfer portion 7Y of the $\phi H1b$ of the horizontal CCD register 5.

After that, at the aforementioned time T1, of the drive pulses of the horizontal CCD register 5, the $\phi H1b$ becomes low level and the $\phi H2a$ becomes high level, so that the signal charge in the transfer portion 7Y of the $\phi H1b$ is transferred to the transfer portion 7X of the $\phi H2a$.

After that, the horizontal scanning interval starts again so that transfer by the horizontal CCD register is carried out by the 4-phase complementary drive.

According to the above described embodiment, if the double speed operation and the normal operation are compared in the horizontal CCD register 5, the phases of the reset gate

pulse ϕ_{RG} and the first drive pulse ϕ_{H1a} of the transfer portion at the final stage are not different between the double speed operation and the normal operation.

Thus, since the CCD output waveform depends on the phases of the drive pulse ϕ_{H1a} at the final stage of the horizontal CCD register 5 and the reset gate pulse ϕ_{RG} , in the system in which the phases of the ϕ_{H1a} and the reset gate pulse ϕ_{RG} are not different from the usual case like this example, the CCD output waveform becomes a waveform of the same waveform, and hence the clamp pulse of the correlated double sampling and the sampling pulse can be used in the same phase.

That is, an interval $Tp5$ for clamping a preset signal, and an interval $Td5$ for sampling a data signal in order to carry out the correlated double sampling have the same width as the intervals $Tp4$ and $Td4$ for the aforementioned double speed operation. Thus, even under the double speed operation, an interval for carrying out the correlated double sampling can be secured sufficiently like the normal operation.

From viewpoints of the system configuration, the frequency for use is desired to be the same. Since the same frequency pulse can be used in the normal operation and the double speed operation, the system can be simplified.

In the above embodiment, the double speed operation is carried out by the complementary drive of four phase. In principle, the horizontal scanning interval can be made $1/N$ by

increasing the number of separation gates or transfer portions to which the drive pulse is to be applied independently so as to perform an N-time speed operation by complementary drive of 2N phase ($N = 2, 3, \dots$; natural number). For example, when a three-time speed operation is carried out, it is sufficient that drive pulses $\phi H1a, \phi H2a, \phi H1b, \phi H2b, \phi H1c, \phi H2c$ are applied to respective transfer electrode successively while $\phi H1a$ and $\phi H2b$, $\phi H2a$ and $\phi H1c$, $\phi H1b$ and $\phi H2c$ are made opposite in phase to each other. Each pair of pulses having opposite phase relation is transferred by 1/3 half waveform.

In this case, the clamp pulse of the correlated double sampling and the sampling hold pulse can be used in the same phase in the normal operation and the N-time speed operation. Even in the N-time speed operation, a sufficient interval for the clamp pulse and the sampling hold pulse can be obtained like in the normal operation.

Because the horizontal scanning interval can be reduced to 1/N as described above, the feedback of AE, AWB, AF or the like is quickened. In addition, the monitor output to a liquid crystal display or the like is made to follow a camera movement.

Next, another embodiment of the CCD imaging device according to the present invention will be described.

In the above described embodiment, as shown in FIG. 10, horizontal two picture elements are added in the horizontal CCD register 5 in the case of the double speed operation. In a

single-plate color CCD, color signals must be separated. Therefore, the CCD imaging device is composed as follows, for example.

In a CCD imaging device 210 shown in FIG. 14, when a signal charge is read from the light receiving portion 2 composed of a photo sensor to the vertical CCD register 4, the signal charge is read from the light receiving portion 2 at every other column.

For example, taking a case in which three color (R, G, B) filters are arranged as shown in the figure as an example (various patterns can be considered about arrangement of the R, G, B color filters), it is so constructed that a first drive pulse $\phi SG1$ and a second drive pulse $\phi SG2$ can be applied independently to the read-out gates 3 of the light receiving portions 2 at an odd number column and at an even number column, respectively.

In the double speed operation, the signals of the light receiving portions at the odd number column are read out by the driving pulse $\phi SG1$ and outputted through the horizontal CCD register 5. After that, the signals of the light receiving portions at the even number are read out by the driving pulse $\phi SG2$ and outputted through the horizontal CCD register 5.

Consequently, the color signals of the respective light receiving portions are not mixed, and the single plate CCD can separate the color signals.

When the imaging device is desired to be driver under

the normal operation mode or the standard mode (so-called two-phase drive), the first and second drive pulses $\phi SG1$ and $\phi SG2$ are applied at the same time, so that all the read-out gates 3 are turned on to thereby read the signals.

As another structure for separation of color signals in the single plate color CCD, as shown in FIG. 15, a structure in which every two columns are read out can be employed.

In the CCD imaging device 310, to read the signal charge from the light receiving portion 2 made of a photo sensor to the vertical CCD register 4, the drive pulse to be applied to the read-out gate portion 3 changes at every third column, the drive pulse being $\phi SG1$ or $\phi SG2$.

That is, on the read-out gate 3, two columns to which the first drive pulse $\phi SG1$ and second the drive pulse $\phi SG2$ are to be applied respectively are arranged in pair such that they come alternately.

In the double speed operation, each pair of two neighboring column of the sensors are supplied with $\phi SG1$ or $\phi SG2$ alternately with a time lag so as to drive the read-out gate portion 3. As a result, the signals of each sensor column are not mixed and color signals can be separated in a single plate CCD. It is permissible to apply only any one of $\phi SG1$ and $\phi SG2$ for driving.

When the standard mode operation is carried out, the drive pulses $\phi SG1$ and $\phi SG2$ are applied at the same time so that

all the read-out gate portions 3 are turned on so as to read.

Meantime, the CCD imaging devices 210, 310 shown in FIGS. 14, 15 can be applied to the N time speed operation. In this case, the read out gate is enabled to be driven at every second ~ N column (for example, when triple speed is applied, every second, third or fourth is selected) and in the N-time speed operation, the read out gate of only a single column of the N columns is turned on so as to read only the 1/N column.

As shown in FIG. 16, it is permissible to apply a structure in which a function of throwing out every second column of the signal charge or every third column thereof is provided in a drain region provided under the horizontal CCD register. FIG. 16 shows an example of a structure in which every second column is thrown out.

The CCD imaging device 410 shown in FIG. 16 has such an arrangement that, under the horizontal CCD register 5 is formed in parallel therewith a drain region 42 through a channel stop 43 for blocking the signal charge from, for example, the vertical CCD register 4 of an odd number and a gate portion 44 for allowing the signal charge from the vertical CCD register 4 of even number to be discharged to the drain region 42.

A gate pulse ϕ_{HDG} is applied to the gate portion 44.

In the double speed operation, the signal charge transferred from the vertical CCD register 4 goes into the horizontal CCD register 5 and then outputted by the horizontal CCD register 5. At this time, the signal charge from the light receiving portion 2 corresponding to the odd number column is

transferred to the horizontal CCD register 5 but the signal charge from the light receiving portion 2 corresponding to the even number column goes through the horizontal CCD register 5 and is thrown out to the drain region 42 through the gate portion 44. Therefore, in the horizontal CCD register 5, only the signal charge of the light receiving portion 2 of the odd number column is transferred and outputted.

By the a structure in which the signal charge of every second light receiving column is thrown out to the drain region 42 through the horizontal CCD register 5, color signals can be separated in the single plate CCD without mixing signals of respective light receiving columns. In the standard mode, the gate portion 44 is turned off so that all the signal charges are transferred to the horizontal CCD register 5.

Although not shown here, in the case of gathering two columns in the neighborhood of the light receiving portion 2 and throwing out every third column as well, signal separation can be carried out in the same manner.

In the case when the CCD imaging device 410 shown in FIG. 16 is applied to the N-time speed operation, the signal charge of one column in the N columns of the light receiving portion 2 is transferred to the horizontal CCD register 5 and the signal charges of N-1 columns of the N columns remained are thrown out to the drain region 42.

The CCD imaging device according to the present invention is not restricted to the above described examples but may be modified in various ways within a range not departing

from a gist of the present invention.

According to the CCD imaging device of the present invention, the horizontal scanning period can be reduced to $1/N$, and therefore feedback of AE, AWB, AF and the like is quickened.

Further, the monitor output to a liquid crystal display or the like can follow a camera motion, so that it is possible to take pictures without losing a shutter chance.

Further, according to the present invention, a sufficient phase margin can be assured for the clamp pulse for clamping the CCD output and the sample hold pulse for sampling even in the N-time speed operation, and therefore production efficiency can be improved.

Further, in the normal operation and the N-time speed operation, the same clamp pulse for clamping the CCD output and the same sampling hold pulse for sampling can be used, and therefore the system can be simplified.

FIG. 17 is a schematic construction diagram showing a CCD area sensor of, for example, an inter-line transfer type according to the present invention. Referring to FIG. 17, an imaging area 113 comprises a plurality of sensor portions (picture elements) 111 which are arranged in a matrix for converting an incident light to a signal charge of a charging amount corresponding to the amount of the incident light and accumulating the same and a plurality of vertical transfer registers 112 which are provided on every vertical column of the sensor portions 111 for transmitting the signal charge read from each of the sensor portions 111 through a read out gate (not

shown) vertically.

In this imaging area 113, each of the sensor portions 111 is made of, for example, a P-N junction type photo diode. The vertical transfer register 112 is driven by, for example, 4-phase vertical transfer clocks $\phi V1-\phi V4$ and the signal charge read from each of the sensor portions 111 is transferred successively in a part of horizontal blanking period by a part corresponding to one scanning line (1 line) each in the vertical direction. Below the imaging area 113 in this figure is disposed a horizontal transfer register 114.

The signal charge corresponding to one line is successively transferred from each of the plural vertical transfer registers 112 to the horizontal transfer register 114. The horizontal transfer register 114 is driven by horizontal transfer clocks $\phi H1a$, $\phi H1b$, $\phi H2$ so that the signal charges of one single line transferred from the plurality of vertical transfer registers 112 are transferred successively in the horizontal direction in the horizontal scanning period after the horizontal blanking period. In this example, as the horizontal transfer clock $\phi H2$, a DC voltage of a predetermined voltage value is supplied.

Vertical transfer clocks $\phi V1-\phi V4$ and horizontal transfer clocks $\phi H1a$, $\phi H1b$ are generated from a timing generator 115. When the normal operation mode is set by a mode setting unit 116, the timing generator 115 generates the horizontal

transfer clocks $\phi H1a$, $\phi H1b$ same in phase as shown in FIG. 18A and when the frame rate increase mode is set, generates the horizontal transfer clocks $\phi H1a$, $\phi H1b$ opposite in phase as shown in FIG. 18B.

At an end of the between side of the horizontal transfer register 114 is provided a charge detecting portion 117 of, for example, a floating diffusion amplifier. This charge detecting portion 117 comprises a floating diffusion (FD) 119 which accumulates the signal charge supplied from the horizontal transfer register 114 through a horizontal output gate (HOG) 118, a reset drain (RD) 120 for draining the signal charge and a reset gate (RG) 121 provided between the floating diffusion 119 and the reset drain 120.

In this charge detecting portion 117, a predetermined reset drain voltage V_{rd} is applied to the reset drain 120 and a reset gate pulse ϕRG is applied to the reset gate 121 in a detection frequency for the signal charge. Then, the signal charge accumulated in the floating diffusion 119 is converted to a signal voltage and delivered as a CCD output signal OUT through an output circuit 122.

FIG. 19 is a sectional view of a charge transfer apparatus of the present invention which is used as the horizontal transfer register 114. Referring to FIG. 19, on the surface of N type substrate 131 is formed an N type transfer channel 133 with a P type well 132 provided therebetween. On the N type transfer channel 133 are arranged gate electrodes

134, 135 of first and second layers made of polysilicone through a gate insulating film (not shown) alternately and repeatedly in the transfer direction. An N- impurity is ion-implanted into the surface of the transfer channel 133 below the gate electrode 135.

As for the arrangement of the gate electrodes 134, 135 of the two-layered structure, the gate electrodes 134, 135 adjacent to each other make a pair and wiring is placed so that the horizontal transfer clock $\phi H1$ ($\phi H1a$, $\phi H1b$) of a first phase and the horizontal transfer clock $\phi H2$ (DC voltage) of a second transfer are applied alternately to each pair of the gate electrodes 134, 135. Further, the wiring for the gate electrodes 134, 135 to which the horizontal transfer clocks $\phi H1a$, $\phi H1b$ of the first phase are to be applied are so structured that the horizontal transfer clock $\phi H1a$ and the horizontal transfer clock $\phi H1b$ are to be applied alternately.

That is, taking a step (n-1), a step n and a step (n+1) as an example in FIG. 19, the horizontal transfer clock $\phi H1a$ is applied to the gate electrodes 134, 135 of the step (n-1), the horizontal transfer clock $\phi H2$ is applied to the gate electrodes 134, 135 of the step n, and the horizontal transfer clock $\phi H1b$ is applied to the gate electrodes 114, 135 of the step (n+1). That is, wiring is placed so that the transfer step of the horizontal transfer clock $\phi H1$ on both sides of the

transfer step of the horizontal transfer clock $\phi H2$ can be driven independently.

The transfer operations in the normal operation mode and the frame rate increase mode of the horizontal transfer register 114 having the aforementioned structure will be described.

First, the transfer operation in the normal operation mode will be described with reference to a timing chart diagram of FIG. 20A and a potential diagram of FIG. 20B. When the normal operation mode is set by the mode setting portion 116, the timing generator 115 generates the horizontal transfer clocks $\phi H1a$, $\phi H1b$ of the same phase as shown in FIG. 20A and supplies the same to the horizontal transfer register 114. Further, the horizontal transfer clock $\phi H2$ is fixed to a DC voltage V_{fix} of a predetermined voltage value.

When the horizontal transfer clock $\phi H2$ is fixed to a DC value, the potential under the gate electrodes 134, 135 to which the horizontal transfer clock $\phi H2$ is applied is set to a level between a potential when the horizontal transfer clocks $\phi H1a$, $\phi H1b$ are at "H" level and a potential when the horizontal transfer clocks $\phi H1a$, $\phi H1b$ are at "L" level, preferably a substantially middle level thereof. This can be realized by implanting an impurity or the clamp inside the CCD.

Because the horizontal transfer clocks $\phi H1a$, $\phi H1b$ are

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at "H" level when $T = T_1$, the potential under the gate electrodes 134, 135 of ϕ_{H1a} , ϕ_{H1b} becomes deeper than the potential under the gate electrodes 134, 135 of ϕ_{H2} . Further, because the N-impurity is ion-implanted in the portion under the gate electrode 135, the potential of a portion under the gate electrode 134 is deeper than that of the portion under the gate electrode 135. Thus, the signal charge of one line amount transferred from the vertical transfer register 112 to the portion under the respective gate electrodes 134, 135 of ϕ_{H1a} , ϕ_{H1b} is accumulated under the gate electrode 134.

Because the horizontal transfer clocks ϕ_{H1a} , ϕ_{H1b} are at "L" level when $T = T_2$, the potential under the gate electrodes 134, 135 of ϕ_{H1a} , ϕ_{H1b} becomes shallower than the potential under the gate electrodes 134, 135 of ϕ_{H2} . Thus, the signal charge accumulated under the gate electrode 134 of ϕ_{H1a} , ϕ_{H1b} is transferred to the portion under the gate electrodes 134, 135 of ϕ_{H2} . Because the potential of the portion under the gate electrode 134 is deeper than that of the portion under the gate electrode 135, the signal charge is accumulated under the gate electrode 134 of ϕ_{H2} .

Because the horizontal transfer clocks ϕ_{H1a} , ϕ_{H1b} become "H" level again when $T = T_3$, the potential under the gate

Electrodes 134, 135 of $\phi H1a$, $\phi H1b$ becomes deeper than that under the gate electrodes 134, 135 of $\phi H2$. Further because the potential under the gate electrode 134 is deeper than that under the gate electrode 135, the signal charge accumulated under the gate electrode 134 of $\phi H2$ is transferred to the gate electrodes 134, 125 of $\phi H1a$, $\phi H1b$ and accumulated under the gate electrode 134.

The same operation is repeated after $T=T4$. By this series of transfer operation, within one cycle of the horizontal transfer clocks $\phi H1a$, $\phi H1b$, the horizontal transfer of the signal charge of one horizontal picture element amount is carried out. The signal charge of one horizontal picture element amount transferred horizontally is supplied successively to the charge detecting portion 117 through the horizontal output gate 118 and converted to a signal voltage at the charge detecting portion 117, and then delivered as a CCD output through an output circuit 122. In the charge detecting portion 117, the reset gate pulse ϕRG is applied to the reset gate (RG) 121 so that the floating diffusion (FD) 119 is reset in the period of the horizontal transfer clocks $\phi H1a$, $\phi H1b$.

Though, in the present example, the horizontal transfer clock $\phi H2$ is fixed to the DC value at the time of the normal operation mode, as shown by one dot, chain line of FIG. 20A, it is permissible to make the horizontal transfer clock $\phi H2$

as a clock in opposite phase of the horizontal transfer clocks $\phi H1a$, $\phi H1b$ so that the gate electrodes 134, 135 of $\phi H2$ and the gate electrodes 134, 135 of $\phi H1a$, $\phi H1b$ are subjected to the complementary 2-phase drive.

Next, the transfer operation at the time of the frame rate increase mode will be described with a timing chart shown in FIG. 21A and a potential diagram shown in FIG. 21B. When the frame rate increase mode is set by the mode setting portion 116, the timing generator 115 generates the horizontal transfer clocks $\phi H1a$, $\phi H1b$ opposite in phase as shown in FIG. 21A and supplies the same to the horizontal transfer register 114. The horizontal transfer clock $\phi H2$ is fixed to a DC voltage V_{fix} of a predetermined voltage value like in the normal operation mode.

Because the horizontal transfer clock $\phi H1a$ is at "H" level and the horizontal transfer clock $\phi H1b$ is at "L" level when $T = T1$, the potential under the gate electrodes 134, 135 of $\phi H1a$ is deep, the potential under the gate electrodes 134, 135 of $\phi H1b$ is shallow and the potential under the gate electrodes 134, 135 of $\phi H2$ is at substantially a middle level therebetween. Further, because the potential under the gate electrode 134 is deeper than the potential under the gate electrode 135, the potential under the gate electrode 135 of $\phi H1b$ is shallowest and the potential under the gate electrode 134 of $\phi H1a$ is deepest,

so that step-like distribution of the potential is attained.

Of the signal charge of one line amount transferred from the vertical transfer register 112 to the respective gate electrodes 134, 135 of $\phi H1a$, $\phi H1b$, the signal charge transferred to the portion under the gate electrodes 134, 135 of $\phi H1b$ moves to the portion under the gate electrodes 134, 115 of $\phi H1a$ through the gate electrodes 134, 135 of $\phi H2$, and accumulated under the gate electrode 134. As a result, during the transfer from the vertical transfer register 112 to the horizontal transfer register 114, the signal charge of two horizontal picture element amount is added.

Because the horizontal transfer clock $\phi H1a$ is at "L" level and the horizontal transfer clock $\phi H1b$ is at "H" level when $T = T2$, the potential under the gate electrodes 134, 135 of $\phi H1a$ becomes shallow and the potential under the gate electrodes 134, 135 of $\phi H1b$ becomes deep. Further because the potential under the gate electrode 134 is deeper than the potential under the gate electrode 135, the potential under the gate electrode 35 of $\phi H1a$ is shallowest and the potential under the gate electrode 134 of $\phi H1b$ is deepest, so that step-like distribution of the potential is attained. As a result, the signal charge of two horizontal picture element amount accumulated under the gate electrode 134 of $\phi H1a$ moves to the portion under the gate

electrodes 134, 135 of $\phi H1b$ through the portion under the gate electrodes 134, 135 of $\phi H2$ and is accumulated under the gate electrode 134.

Because the horizontal transfer clock $\phi H1a$ is at "H" level and the horizontal transfer clock $\phi H1b$ is at "L" level again when $T = T3$, the potential under the gate electrodes 134, 135 of $\phi H1a$ becomes deep and the potential under the gate electrodes 134, 135 of $\phi H1b$ becomes shallow. Further, because the potential under the gate electrode 134 is deeper than the potential under the gate electrode 135, the potential under the gate electrode 134 of $\phi H1a$ is deepest and the potential under the gate electrode 135 of $\phi H1b$ is shallowest so that step-like distribution of the potential is attained. As a result, the signal charge of two horizontal picture element amount accumulated under the gate electrode 134 of $\phi H1b$ moves to the portion under the gate electrodes 134, 135 of $\phi H1a$ through the portion under the gate electrodes 134, 135 of $\phi H1b$ and is accumulated under the gate electrode 134.

The same operation is repeated after $T = T4$. By this sequential transfer operation, the horizontal transfer of the signal charge of two horizontal picture element amount is carried out in one cycle of the horizontal transfer clocks $\phi H1a$,

value. The respective gate electrodes 134, 135 of $\phi H1a$, $\phi H1b$ are driven by the complementary 2-phase. Thus, the following operation and effect are obtained.

That is, in the frame rate increase mode, by fixing the $\phi H2$ to the DC value, subjecting the respective gate electrodes 134, 135 of $\phi H1a$, $\phi H2$ to the complementary 2-phase drive and then regarding $\phi H1a$, $\phi H2$, $\phi H1b$, $\phi H2$ as one cycle for the horizontal transfer, the transfer with addition of the signal charge of two horizontal picture element amount can be carried out. Thus, the output period of one horizontal line can be made half without changing the horizontal drive frequency so as to increase the frame rate. Conversely, if the frame rate is made to be constant, the horizontal drive frequency can be reduced, so that power consumption can be reduced.

If the $\phi H1a$ according to the present invention is made to be of the same timing (same phase) with respect to the $\phi H1$ at the final step of a conventional horizontal transfer register, the same waveform as before can be obtained in terms of the CCD output waveform (same as before in terms of frequency and phase). Therefore, the same sampling as conventionally can be carried out without changing the CD pulse such as clamp pulse and the sample hold pulse in the signal processing system in the a following stage.

Here, the frame rate increase mode is set in a case of photometry or the like for exposure adjustment, for example, in

a case when it is applied to a camera system. Therefore, by increasing the frame rate, the feedback for photometry or the like at the time of exposure adjustment is made rapid. Further, in the CCD area sensor of high picture element, by setting the frame rate increase mode, monitoring by a monitor of a television type such as the NTSC or the like is enabled.

Although the above embodiment is formed so that the DC value which is the horizontal transfer clock $\phi H2$ is given from outside of the CCD chip, it is permissible to so construct that the DC value is generated inside the CCD chip and this DC value is used in the horizontal transfer register 114 as the horizontal transfer clock $\phi H2$. According to this structure, the horizontal transfer clock terminal can perform its function with two pieces like conventionally. Thus, it is possible to realize the CCD area sensor having a change-over function between the normal operation mode and the frame rate increase mode without increasing the number of terminals.

Although the case in which the present invention is applied to the horizontal transfer register of the CCD area sensor of the inter-line transfer (IT) system has been described in the above embodiment, it can be applied also to the horizontal transfer register of a CCD area sensor of the frame transfer (FT) system or the frame inter-line transfer (FIT) system. Further, this can be applied to not only the area sensor but also the charge transfer portion of a linear sensor and the charge transfer portion of a CCD delay line as well as that of a solid-state imaging device.

By applying this invention to the charge transfer portion of the linear sensor and switching between the normal operation mode and the frame rate increase mode, the resolution can be changed over in one linear sensor. For example, change-over between a high resolution (2000 picture elements) mode and a low resolution/high speed (1000 picture elements) mode can be carried out by a linear sensor having 2000 picture elements. As for application, in a case in which it is permitted to reduce a resolution for pre-scan or the like in an image reading portion of a copier or the like, use of a high speed mode can be considered. On the other hand, when it is applied to the charge transfer portion of the CD delay line, the transfer efficiency can be improved by setting the frame rate increase mode.

In the above embodiments, the case of application to the monochrome CCD area sensor has been described. Because the signal charge of two horizontal picture elements is added to the horizontal transfer register 114, if this is applied to a single plate color CCD area sensor, color separation may not be realized. Then, various application examples in which the present invention is applied to the single plate CCD area sensor using, for example, 2×2 or 2×4 G checkered pattern arrangement original color filter so as to allow color separation will be described below.

FIG. 22 is a schematic construction diagram showing a sixth embodiment of the present invention in which the same reference numerals are attached to the same components in FIG. 17. In this sixth embodiment, as a read out gate for reading a

signal charge from the sensor 111 to the vertical transfer register 112, two systems of reading out gates 141a, 141b are provided such that, with respect to repetition of two picture elements of color filter in the horizontal direction, two columns of the picture elements are arranged with one picture element transferred alternately at every two columns. The two systems of read out gates 41a, 41b can be driven by two kinds of read out gate pulses $\phi SG1$, $\phi SG2$ independently.

In this color CCD area sensor according to the sixth example, in the frame rate increase mode, by generating only the read out gate pulse ϕSG when reading the signal charge from the sensor portion 111, the reading is performed by only one read out gate 141a of two read out gates 141a, 141b provided here. As a result, even if the horizontal transfer register 114 is driven by the frame rate increase mode described in FIGS. 21A, 21B, only one color signal charge of two horizontal colors of the color filter is transferred from the vertical transfer register 112 to the horizontal transfer register 14 (VH transfer) in one cycle of the horizontal transfer register 114 (corresponding to two horizontal picture element amount during the normal operation). Thus, two horizontal picture elements (ϕ two colors) of the color filter can be separated.

On the other hand, in the normal operation mode, by generating two kinds of read out gate pulses $\phi SG1$, $\phi SG2$ at the same timing, two systems of read out gates 41a, 41b are driven in the same phase so as to read the signal charge from all the

columns. Consequently, the signal charges of two horizontal colors of the color filter are transferred in the VH fashion. As described in FIGS. 20A, 20B, the signal charge is transferred horizontally one by one horizontal picture element each in one cycle of the horizontal transfer register 114.

FIG. 23 is a schematic construction diagram showing a seventh embodiment of the present invention. The same reference numerals are attached to the same components as in FIG. 17. According to the seventh embodiment, in a transfer path from the vertical transfer register 112 to the horizontal transfer register 114, there is provided a control gate portion 142, which selectively prevents the VH transfer for repetition of two picture of the color filter in the horizontal direction with one picture element transferred and which transfer signal charges of only remaining picture elements to the horizontal transfer register 114.

FIG. 24 shows an example of a structure of the control gate portion 142. Referring to FIG. 24, the control gate portion 142 comprises a transfer blocking portion 143 for blocking the VH transfer of the signal charge of every two picture elements in the horizontal direction by being supplied with a "L" level hold pulse ϕ HOLD and a charge discharging portion 144 for discharging the transfer-blocked signal charge. The transfer blocking portion 143 has a hold gate electrode 146 disposed above a transfer channel 145 of the vertical transfer register 112 for two column amounts and a hold pulse ϕ HOLD is applied to this hold gate electrode 146.

On the other hand, the charge discharging portion 144 comprises a guide channel 147 which connects the respective transfer channels 145, 145 of the adjacent vertical transfer registers 112 so as to guide the signal charge blocked by the transfer blocking portion 143 and a drain 148 for discharging the signal charge flowing from the transfer channel 145 of the vertical transfer register 112 through the guide channel 147 to a substrate. Meantime, the structure of the above described transfer blocking portion 143 and charge discharging portion 144 is only an example, and is not limited to this example.

In the color CCD area sensor according to the seventh embodiment, in the frame rate increase mode, by applying the "L" level hold pulse ϕ HOLD to the hold gate electrode 146 during the VH transfer, the potential under the hold gate electrode 146 becomes shallow in the transfer channel 145 because of repetition of two picture elements in the horizontal direction of the color filter with one picture element amount transferred specially, so that the VH transfer is blocked by the repetition of two picture elements in the horizontal direction.

The signal charge blocked by the transfer blocking portion 143 is swept out to the drain 148 through the guide channel 147. Therefore, even if the horizontal transfer register 114 is driven in the frame rate increase mode described in FIGS. 21A, 21B, the signal charge of only one of two horizontal colors of the color filter is transferred in the VH fashion in one cycle (corresponding to two horizontal picture elements during the normal operation) of the horizontal transfer

register 114, so that two horizontal picture elements (two colors) of the color filter can be separated.

On the other hand, because in the normal operation mode, the hold pulse ϕHOLD becomes to "H" level, the potential under the hold gate electrode 146 in the transfer channel 145 becomes deep. Consequently, transfer blocking is not carried out in the transfer blocking portion 143 and the VH transfer is carried out in all the columns. Thus, although the signal charges of the two horizontal colors of the color filter are transferred in the VH fashion, as described in FIGS. 20A, 20B, the signal charge is transferred horizontally one by one in one cycle of the horizontal transfer register 114.

FIG. 25 is a schematic construction diagram showing an eighth embodiment of the present invention. In this figure, the same reference numerals are attached to the same components as in FIG. 17. According to the eighth embodiment, a sweeping gate 51 is provided adjacent to the horizontal transfer register 114 on an opposite side to the imaging area 113 of the horizontal transfer register 114 and a drain 152 is provided outside of the sweeping gate 151. The sweeping gate 151 is formed in such a manner that two picture elements are repeated with one picture element transferred with respect to each of the transfer stages corresponding to the picture elements of the horizontal transfer register 114.

A sweeping gate pulse ϕHOB is selectively applied to the sweeping gate 151. The sweeping gate 151 sweeps the signal charge corresponding to a transfer stage in the horizontal

transfer register 114 by being supplied with sweeping gate pulse ϕ_{HOB} into the drain 152. Meantime, a region (hatched portion) 153 corresponding to two picture elements between the sweeping gates 151 is channel stop region.

In the color CCD area sensor according to the eighth embodiment of the present invention, in the frame rate increase mode, when the "H" level sweeping gate pulse ϕ_{HOB} is applied to the sweeping gate 115 during the VH transfer, the potential under the sweeping gate 151 becomes deep. Thus, the signal charge VH-transferred from the respective vertical transfer register 112 to the horizontal transfer register 114 is swept out to the drain 152 through the sweeping gate 151 such that two picture elements are repeated with one picture element transferred. As a result, separation of the horizontal two picture elements (two colors) in the color filter can be carried out.

Although in the previously described embodiment, the signal charge of two horizontal picture element amount is added at the transfer stage from the vertical transfer register 112 to the horizontal transfer register 114, according to the eighth embodiment, when the transfer is carried out from the vertical transfer register 112 to the horizontal transfer register 114, the signal charges VH-transferred to the transfer stage of the gate electrodes 134, 135 of ϕ_{H1a} and the transfer stage of the gate electrodes 134, 135 of ϕ_{H1b} must be separated. To this end, at the time of the VH transfer, both the horizontal

Transfer clocks $\phi H1a$, $\phi H1b$ must be made at "H" level. Then, when the horizontal transfer operation starts, the horizontal transfer clocks $\phi H1a$, $\phi H1b$ are reversed in phase.

On the other hand, when the sweeping gate pulses $\phi H1a$, ϕHOB to be applied to the sweeping gate 151 are made to "L" level in the normal operation mode, the potential under the sweeping gate 151 becomes shallow. Thus, sweeping of the signal charge from the sweeping gate 151 to the drain 152 is not carried out and the signal charges are accumulated in all the transfer stages of the horizontal transfer register 114. Then, as described in FIGS. 22A, 22B, the signal charges are transferred horizontally successively in order of each horizontal picture element in one cycle of the horizontal transfer register 114.

As shown in the sixth - eighth embodiments, by thinning the signal charge in the horizontal direction by repetition of two picture elements in the horizontal direction with one picture transferred, for the repetition of two horizontal picture elements of the color filter color separation can be carried out securely even when the present invention is applied to a single plate color CCD area sensor. Although in the sixth - eighth embodiments, a case in which the present invention is applied to the 2 x 2 or 2 x 4 G checkered arrangement original color filter has been described, the color arrangement is not restricted to this example. Further, the

present invention is applicable to a complementary color filter.

Although the sixth - eighth embodiments have been made for color separation in the single plate color CCD area sensor, the thinning operation for the signal charges in the horizontal direction can be applied to a monochrome CCD area sensor thereby improving its frame rate. Further, by combining this thinning operation for the signal charges in the horizontal direction, with a conventional thinning operation by sweeping the signal charges in the vertical direction to the drain adjacent to the horizontal transfer register 114, the frame rate can be further improved.

In a case of a CCD area sensor having 1280 (H) \times 980 (V), picture elements that is, 1,200,000 picture elements, by carrying out the thinning operation for the signal charges in the horizontal direction described in the seventh (FIG. 23) and eighth (FIG. 25) embodiments, and, as for the vertical direction, carrying out the thinning operation by reading two lines each through two systems of read out gates, it is possible to output to a VGA (video graphics array) or a NTSC/PAL monitor without deviating the optical center from the normal operation mode.

According to the present invention, there is provided a charge transfer portion comprising first phase and second phase electrode pairs arranged alternately in the transfer direction above the transfer channel and having such an electrode structure that the first phase electrode pair is wired so as to be driven independently across the second phase

electrode pair. While a DC voltage is supplied to the second phase electrode pair, transfer clocks of opposite phase are supplied to each of the first phase electrode pair sandwiching the second phase electrode pair so as to achieve the complementary 2-phase drive. Thus, the transfer operation is carried out with one of the first phase electrode pair, the second phase electrode pair, the other of the first electrode pair, and second phase electrode pair as one single cycle. Thus, the signal charge of two picture element amount in the transfer direction can be added together and transferred. Therefore, the output period of a horizontal line can be reduced to half without changing the horizontal drive frequency, thereby increasing the frame rate.

Having described preferred embodiments of the present invention with reference to the accompanying drawings, it is to be understood that the present invention is not limited to the above-mentioned embodiments and that various changes and modifications can be effected therein by one skilled in the art without departing from the spirit or scope of the present invention as defined in the appended claims.